

Silicon Power Transistors

The MJL21193 and MJL21194 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

- Total Harmonic Distortion Characterized
- High DC Current Gain -

h_{FE} = 25 Min @ I_C

= 8 Adc

- Excellent Gain Linearity
- High SOA: 2.25 A, 80 V, 1 Second

MJL21193*

*ON Semiconductor Preferred Device

16 AMPERE **COMPLEMENTARY SILICON POWER TRANSISTORS 250 VOLTS 200 WATTS**



MAXIMUM RATINGS

Rating	Symb ol	Value	Unit
Collector–Emitter Voltage	VCEO	250	Vdc
Collector–Base Voltage	VCBO	400	Vdc
Emitter-Base Voltage	V _{EBO}	5	Vdc
Collector–Emitter Voltage – 1.5 V	VCEX	400	Vdc
Collector Current — Continuous Peak (1)	IC	16 30	Adc
Base Current – Continuous	ΙΒ	5	Adc
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	PD	200 1.43	Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic		Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.7	°C/W

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit	
OFF CHARACTERISTICS						
Collector–Emitter Sustaining Voltage (I _C = 100 mAdc, I _B = 0)	VCEO(sus)	250	_	_	Vdc	
Collector Cutoff Current (V _{CE} = 200 Vdc, I _B = 0)	ICEO	_	_	100	μAdc	

⁽¹⁾ Pulse Test: Pulse Width = 5.0 μs, Duty Cycle ≤10%.

(continued)

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS						
Emitter Cutoff Current (V _{CE} = 5 Vdc, I _C = 0)		I _{EBO}	_	_	100	μAdc
Collector Cutoff Current (V _{CE} = 250 Vdc, V _{BE(off)} = 1.5 Vdc)		ICEX	_	_	100	μAdc
SECOND BREAKDOWN		-		•		•
Second Breakdown Collector Current with Base Form (VCE = 50 Vdc, t = 1 s (non-repetitive) (VCE = 80 Vdc, t = 1 s (non-repetitive)	vard Biased	I _{S/b}	4.0 2.25		_ _	Adc
ON CHARACTERISTICS						
DC Current Gain (I _C = 8 Adc, V _{CE} = 5 Vdc) (I _C = 16 Adc, I _B = 5 Adc)		hFE	25 8		75 —	
Base–Emitter On Voltage (I _C = 8 Adc, V _{CE} = 5 Vdc)		VBE(on)	_	_	2.2	Vdc
Collector–Emitter Saturation Voltage (I _C = 8 Adc, I _B = 0.8 Adc) (I _C = 16 Adc, I _B = 3.2 Adc)		VCE(sat)	_	_	1.4 4	Vdc
DYNAMIC CHARACTERISTICS						
11110	h _{FE}	T _{HD}		0.8	_	%
(Matched pair hFE = 50 @ 5 A/5 V)	h _{FE} matched		_	0.08	_	
Current Gain Bandwidth Product (I _C = 1 Adc, V _{CE} = 10 Vdc, f _{test} = 1 MHz)		fT	4	_	_	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1 MHz)		C _{ob}	_	_	500	pF

⁽¹⁾ Pulse Test: Pulse Width = 300 µs, Duty Cycle ≤2%

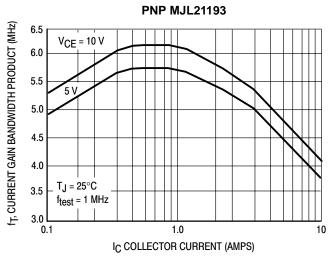


Figure 1. Typical Current Gain Bandwidth Product

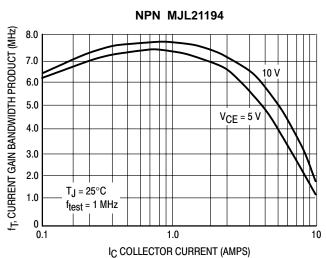


Figure 2. Typical Current Gain Bandwidth Product

TYPICAL CHARACTERISTICS

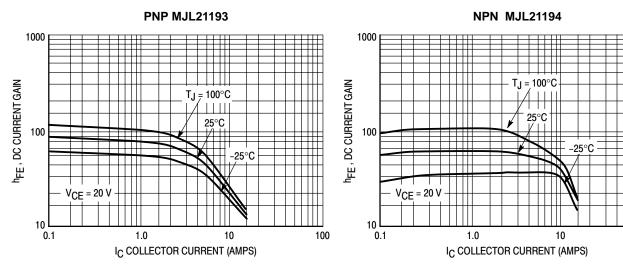


Figure 3. DC Current Gain, V_{CE} = 20 V

Figure 4. DC Current Gain, V_{CE} = 20 V

100

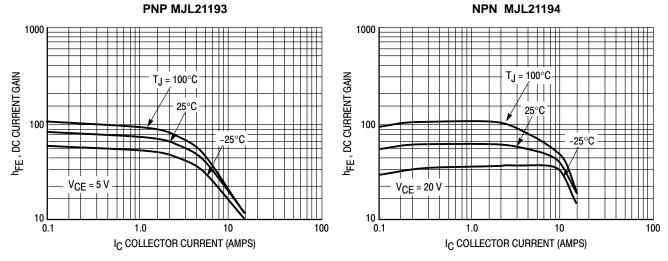
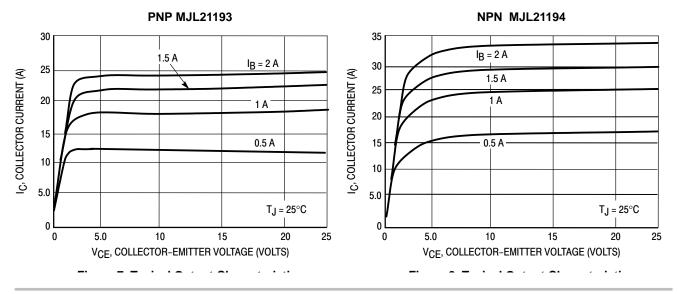


Figure 5. DC Current Gain, VCE = 5 V

Figure 6. DC Current Gain, VCE = 5 V



TYPICAL CHARACTERISTICS

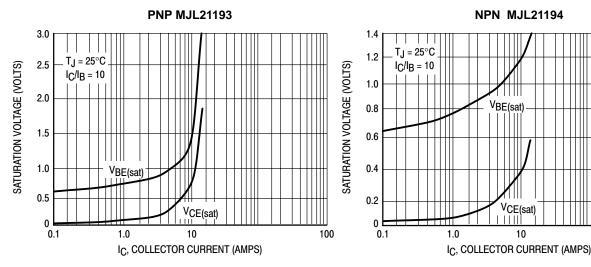


Figure 9. Typical Saturation Voltages

Figure 10. Typical Saturation Voltages

100

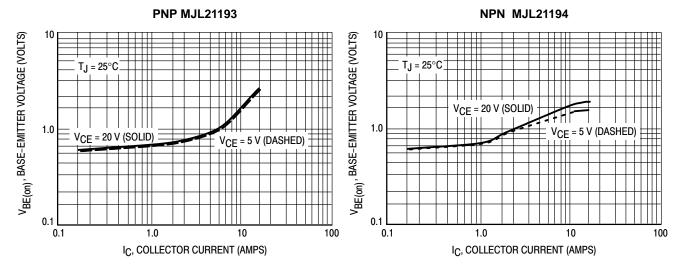


Figure 11. Typical Base-Emitter Voltage

Figure 12. Typical Base–Emitter Voltage

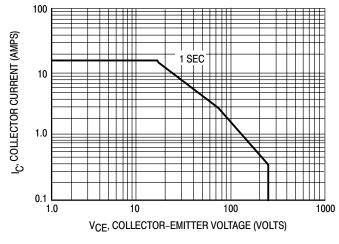


Figure 13. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on $T_{J(pk)} = 150^{\circ}C$; T_{C} is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

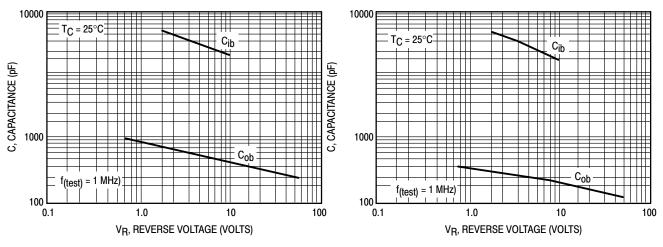


Figure 14. MJL21193 Typical Capacitance

Figure 15. MJL21194 Typical Capacitance

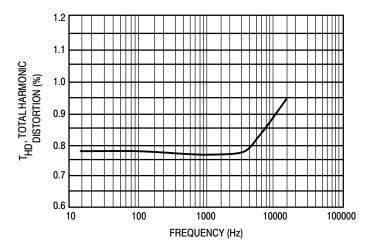


Figure 16. Typical Total Harmonic Distortion

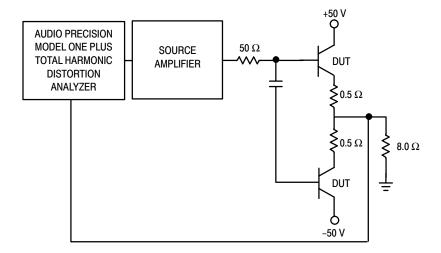
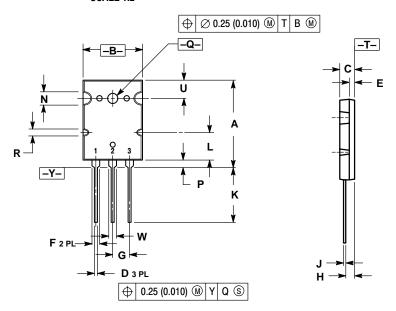


Figure 17. Total Harmonic Distortion Test Circuit

PACKAGE DIMENSIONS

TO-3PBL (TO-264) CASE 340G-02 **ISSUE H**

SCALE 1:2



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	28.0	29.0	1.102	1.142
В	19.3	20.3	0.760	0.800
С	4.7	5.3	0.185	0.209
D	0.93	1.48	0.037	0.058
E	1.9	2.1	0.075	0.083
F	2.2	2.4	0.087	0.102
G	5.45	BSC	0.215	BSC
Н	2.6	3.0	0.102	0.118
J	0.43	0.78	0.017	0.031
K	17.6	18.8	0.693	0.740
L	11.0	11.4	0.433	0.449
N	3.95	4.75	0.156	0.187
P	2.2	2.6	0.087	0.102
Q	3.1	3.5	0.122	0.137
R	2.15	2.35	0.085	0.093
U	6.1	6.5	0.240	0.256
W	2.8	3.2	0.110	0.125



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